Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	٢
10/725,495	FRANK, RUTH	
Examiner	Art Unit	
Tai T. Nguyen	2612	

	SEARCHED		
Class	Subclass	Date	Examiner
340	568.1 566 571 691	1/18/2007	TN
705	2 3	1/18/2007	TN
206	557 561 581	1/18/2007	TN
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